

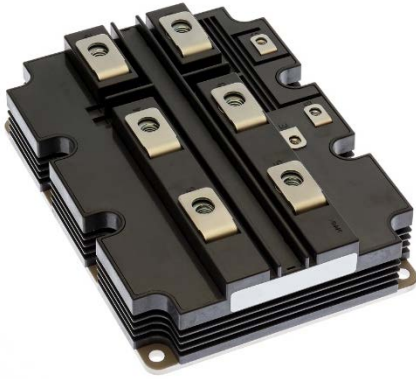
< High Voltage Insulated Gate Bipolar Transistor : HVIGBT >

# CM900HG-130X

HIGH POWER SWITCHING USE  
INSULATED TYPE

5th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

## CM900HG-130X



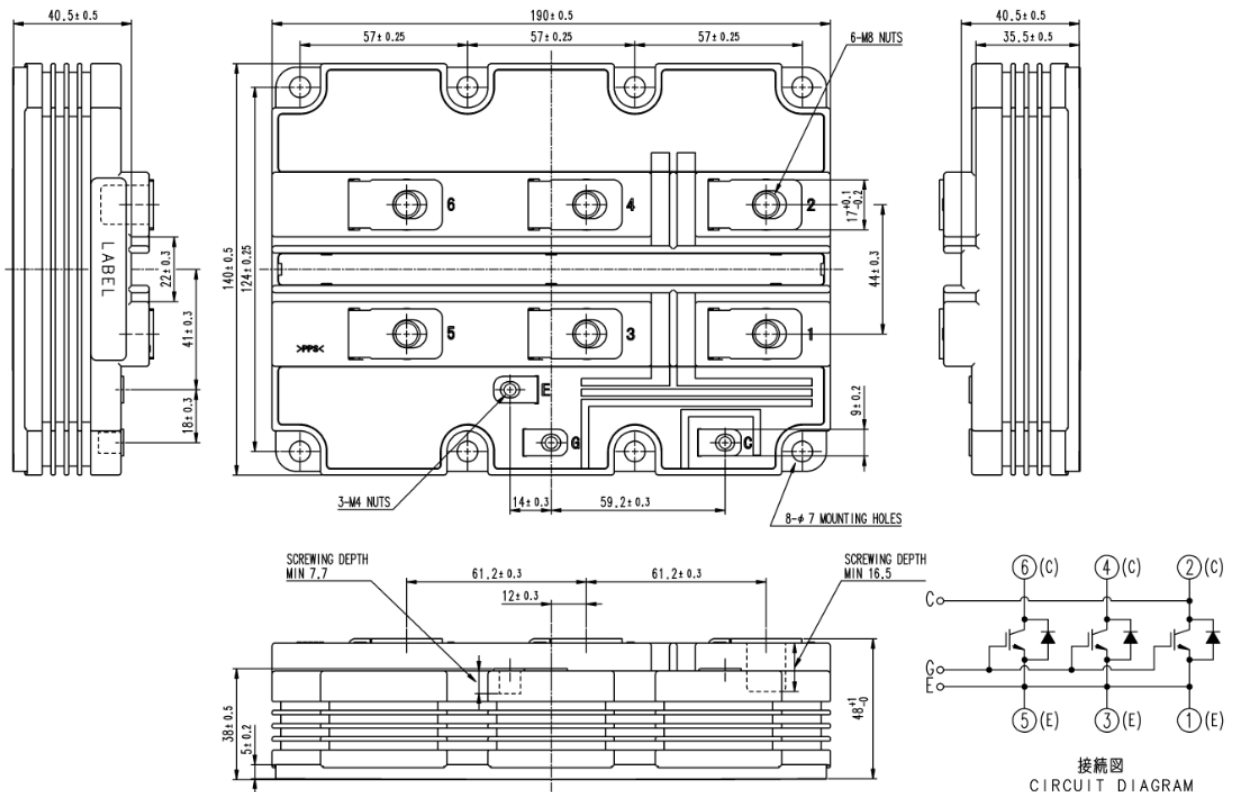
- $I_C$ .....900A
- $V_{CES}$ .....6500V
- 1-element in a Pack
- High Insulated Type
- CSTBT™(III) / RFC Diode
- AISiC Baseplate

## APPLICATION

Traction drives, High Reliability Converters / Inverters, DC choppers

## OUTLINE DRAWING & CIRCUIT DIAGRAM

Dimensions in mm



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**MAXIMUM RATINGS**

Symbol	Item	Conditions	Ratings	Unit
V <sub>CES</sub>	Collector-emitter voltage	V <sub>GE</sub> = 0V, T <sub>j</sub> = 150°C	6500	V
		V <sub>GE</sub> = 0V, T <sub>j</sub> = 25°C	6300	
		V <sub>GE</sub> = 0V, T <sub>j</sub> = -50°C	5700	
V <sub>GES</sub>	Gate-emitter voltage	V <sub>CE</sub> = 0V, T <sub>j</sub> = 25°C	± 20	V
I <sub>C</sub>	Collector current	DC, T <sub>c</sub> = 115°C	900	A
I <sub>CRM</sub>		Pulse (Note 1)	1800	A
I <sub>E</sub>	Emitter current (Note 2)	DC, T <sub>c</sub> = 95°C	900	A
I <sub>ERM</sub>		Pulse (Note 1)	1800	A
P <sub>tot</sub>	Maximum power dissipation (Note 3)	T <sub>c</sub> = 25°C, IGBT part	12500	W
V <sub>iso</sub>	Isolation voltage	RMS, sinusoidal, f = 60Hz, t = 1 min.	10200	V
V <sub>e</sub>	Partial discharge extinction voltage	RMS, sinusoidal, f = 60Hz, Q <sub>PD</sub> ≤ 10pC	5100	V
T <sub>j</sub>	Junction temperature		-50 ~ +150	°C
T <sub>jop</sub>	Operating junction temperature		-50 ~ +150	°C
T <sub>stg</sub>	Storage temperature		-55 ~ +150	°C
t <sub>psc</sub>	Short circuit pulse width	V <sub>CC</sub> = 4500V, V <sub>CE</sub> ≤ V <sub>CES</sub> , V <sub>GE</sub> = 15V, T <sub>j</sub> = 150°C	10	µs

**ELECTRICAL CHARACTERISTICS**

Symbol	Item	Conditions	Limits			Unit	
			Min	Typ	Max		
I <sub>CES</sub>	Collector cutoff current	V <sub>CE</sub> = V <sub>CES</sub> , V <sub>GE</sub> = 0V	T <sub>j</sub> = 25°C	—	—	6.0	mA
			T <sub>j</sub> = 125°C	—	5.0	—	
			T <sub>j</sub> = 150°C	—	90.0	—	
V <sub>GE(th)</sub>	Gate-emitter threshold voltage	V <sub>CE</sub> = 10V, I <sub>C</sub> = 90mA, T <sub>j</sub> = 25°C	6.5	7.0	7.5	V	
I <sub>GES</sub>	Gate leakage current	V <sub>GE</sub> = V <sub>GES</sub> , V <sub>CE</sub> = 0V, T <sub>j</sub> = 25°C	-0.5	—	0.5	µA	
C <sub>ies</sub>	Input capacitance	V <sub>CE</sub> = 10V, V <sub>GE</sub> = 0V, f = 100kHz T <sub>j</sub> = 25°C	—	151	—	nF	
C <sub>oes</sub>	Output capacitance		—	6.3	—	nF	
C <sub>res</sub>	Reverse transfer capacitance		—	0.8	—	nF	
Q <sub>G</sub>	Total gate charge	V <sub>CC</sub> = 3600V, I <sub>C</sub> = 900A, V <sub>GE</sub> = ±15V	—	9.9	—	µC	
V <sub>CESat</sub>	Collector-emitter saturation voltage	I <sub>C</sub> = 900A (Note 4) V <sub>GE</sub> = 15V	T <sub>j</sub> = 25°C	—	2.50	—	V
			T <sub>j</sub> = 125°C	—	3.20	—	
			T <sub>j</sub> = 150°C	—	3.30	3.80	
t <sub>d(on)</sub>	Turn-on delay time	V <sub>CC</sub> = 3600V I <sub>C</sub> = 900A V <sub>GE</sub> = ±15V R <sub>G(on)</sub> = 4.3Ω L <sub>s</sub> = 150nH t <sub>on,diode</sub> = 60µs Inductive load	T <sub>j</sub> = 25°C	—	—	—	µs
			T <sub>j</sub> = 125°C	—	0.55	—	
			T <sub>j</sub> = 150°C	—	0.55	1.45	
t <sub>r</sub>	Rise time	V <sub>CC</sub> = 3600V I <sub>C</sub> = 900A V <sub>GE</sub> = ±15V R <sub>G(on)</sub> = 4.3Ω L <sub>s</sub> = 150nH t <sub>on,diode</sub> = 60µs Inductive load	T <sub>j</sub> = 25°C	—	—	—	µs
			T <sub>j</sub> = 125°C	—	0.20	—	
			T <sub>j</sub> = 150°C	—	0.20	0.50	
E <sub>on(10%)</sub>	Turn-on switching energy (per pulse) (Note 5)	V <sub>CC</sub> = 3600V I <sub>C</sub> = 900A V <sub>GE</sub> = ±15V R <sub>G(on)</sub> = 4.3Ω L <sub>s</sub> = 150nH t <sub>on,diode</sub> = 60µs Inductive load	T <sub>j</sub> = 25°C	—	—	—	J
			T <sub>j</sub> = 125°C	—	6.60	—	
			T <sub>j</sub> = 150°C	—	7.00	—	
E <sub>on</sub>	Turn-on switching energy (per pulse) (Note 6)	V <sub>CC</sub> = 3600V I <sub>C</sub> = 900A V <sub>GE</sub> = ±15V R <sub>G(on)</sub> = 4.3Ω L <sub>s</sub> = 150nH t <sub>on,diode</sub> = 60µs Inductive load	T <sub>j</sub> = 25°C	—	—	—	J
			T <sub>j</sub> = 125°C	—	6.70	—	
			T <sub>j</sub> = 150°C	—	7.20	—	
t <sub>d(off)</sub>	Turn-off delay time	V <sub>CC</sub> = 3600V I <sub>C</sub> = 900A V <sub>GE</sub> = ±15V R <sub>G(off)</sub> = 30Ω L <sub>s</sub> = 150nH t <sub>on,IGBT</sub> ≥ 200µs Inductive load	T <sub>j</sub> = 25°C	—	—	—	µs
			T <sub>j</sub> = 125°C	—	7.0	—	
			T <sub>j</sub> = 150°C	—	7.0	10.5	
t <sub>f</sub>	Fall time	V <sub>CC</sub> = 3600V I <sub>C</sub> = 900A V <sub>GE</sub> = ±15V R <sub>G(off)</sub> = 30Ω L <sub>s</sub> = 150nH t <sub>on,IGBT</sub> ≥ 200µs Inductive load	T <sub>j</sub> = 25°C	—	—	—	µs
			T <sub>j</sub> = 125°C	—	1.00	—	
			T <sub>j</sub> = 150°C	—	1.00	1.50	
E <sub>off(10%)</sub>	Turn-off switching energy (per pulse) (Note 5)	V <sub>CC</sub> = 3600V I <sub>C</sub> = 900A V <sub>GE</sub> = ±15V R <sub>G(off)</sub> = 30Ω L <sub>s</sub> = 150nH t <sub>on,IGBT</sub> ≥ 200µs Inductive load	T <sub>j</sub> = 25°C	—	—	—	J
			T <sub>j</sub> = 125°C	—	5.80	—	
			T <sub>j</sub> = 150°C	—	6.00	—	
E <sub>off</sub>	Turn-off switching energy (per pulse) (Note 6)	V <sub>CC</sub> = 3600V I <sub>C</sub> = 900A V <sub>GE</sub> = ±15V R <sub>G(off)</sub> = 30Ω L <sub>s</sub> = 150nH t <sub>on,IGBT</sub> ≥ 200µs Inductive load	T <sub>j</sub> = 25°C	—	—	—	J
			T <sub>j</sub> = 125°C	—	6.00	—	
			T <sub>j</sub> = 150°C	—	6.20	—	

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## ELECTRICAL CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit	
			Min	Typ	Max		
$V_{EC}$	Emitter-collector voltage (Note 2)	$I_E = 900A$ (Note 4) $V_{GE} = 0V$	$T_J = 25^\circ C$	—	2.50	—	V
			$T_J = 125^\circ C$	—	3.20	—	
			$T_J = 150^\circ C$	—	3.30	3.80	
$t_{rr}$	Reverse recovery time (Note 2)		$T_J = 25^\circ C$	—	—	—	$\mu s$
			$T_J = 125^\circ C$	—	1.75	—	
			$T_J = 150^\circ C$	—	1.80	—	
$I_{rr}$	Reverse recovery current (Note 2)		$T_J = 25^\circ C$	—	—	—	A
			$T_J = 125^\circ C$	—	1250	—	
			$T_J = 150^\circ C$	—	1300	—	
$Q_{rr(10\%)}$	Reverse recovery charge (Note 2, 7)	$V_{CC} = 3600V$ $I_C = 900A$ $V_{GE} = \pm 15V$ $R_{G(on)} = 4.3\Omega$ $L_S = 150nH$ $t_{on\_diode} = 60\mu s$ Inductive load	$T_J = 25^\circ C$	—	—	—	$\mu C$
			$T_J = 125^\circ C$	—	1800	—	
			$T_J = 150^\circ C$	—	2000	—	
$Q_{rr}$	Reverse recovery charge (Note 2, 6)		$T_J = 25^\circ C$	—	—	—	$\mu C$
			$T_J = 125^\circ C$	—	1850	—	
			$T_J = 150^\circ C$	—	2050	—	
$E_{rec(10\%)}$	Reverse recovery energy (per pulse) (Note 2, 5)		$T_J = 25^\circ C$	—	—	—	J
			$T_J = 125^\circ C$	—	3.70	—	
			$T_J = 150^\circ C$	—	4.30	—	
$E_{rec}$	Reverse recovery energy (per pulse) (Note 2, 6)		$T_J = 25^\circ C$	—	—	—	J
			$T_J = 125^\circ C$	—	4.10	—	
			$T_J = 150^\circ C$	—	4.70	—	

## THERMAL CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit
			Min	Typ	Max	
$R_{th(f-c)Q}$	Thermal resistance	Junction to Case, IGBT part	—	—	10.0	K/kW
$R_{th(f-c)D}$		Junction to Case, FWDi part	—	—	16.0	K/kW
$R_{th(c-s)}$	Contact thermal resistance	Case to heat sink, $\lambda_{grease} = 1W/m \cdot k$ , $D_{(c-s)} = 80\mu m$	—	5.0	—	K/kW

## MECHANICAL CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit
			Min	Typ	Max	
$M_t$	Mounting torque	M8 : Main terminals screw	7.0	—	19.0	N·m
$M_s$		M6 : Mounting screw	3.0	—	6.0	N·m
$M_t$		M4 : Auxiliary terminals screw	1.0	—	3.0	N·m
$m$	Mass		—	1.5	—	kg
CTI	Comparative tracking index		600	—	—	—
$d_a$	Clearance		26.0	—	—	mm
$d_s$	Creepage distance		56.0	—	—	mm
$L_{PCE}$	Parasitic stray inductance		—	13.5	—	nH
$R_{CC+EE}$	Internal lead resistance	$T_C = 25^\circ C$	—	0.12	—	mΩ

Note1. Pulse width and repetition rate should be such that junction temperature ( $T_J$ ) does not exceed  $T_{Jopmax}$  rating.

Note2. The symbols represent characteristics of the anti-parallel, emitter to collector free-wheel diode (FWDi).

Note3. Junction temperature ( $T_J$ ) should not exceed  $T_{Jmax}$  rating (150°C).

Note4. Pulse width and repetition rate should be such as to cause negligible temperature rise.

Note5. The integration range of switching energies is from 10% $V_{CE}$  to 10% $I_C$ (10% $I_E$ ).

Note6. Definition of all items is according to IEC 60747, unless otherwise specified.

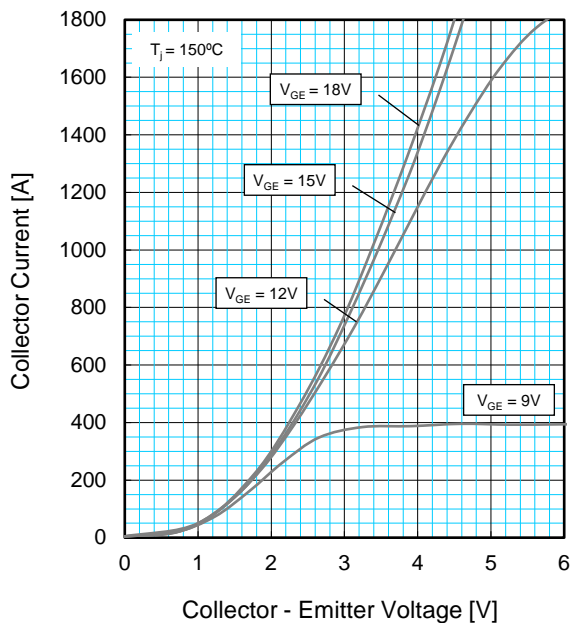
Note7. The integration range of reverse recovery charge is from  $I_E = 0A$  to 10% $I_E$ .

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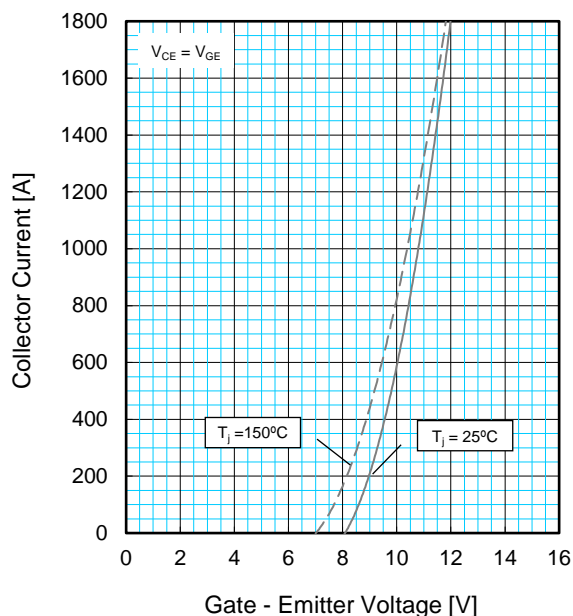
HIGH POWER SWITCHING USE  
INSULATED TYPE

## PERFORMANCE CURVES

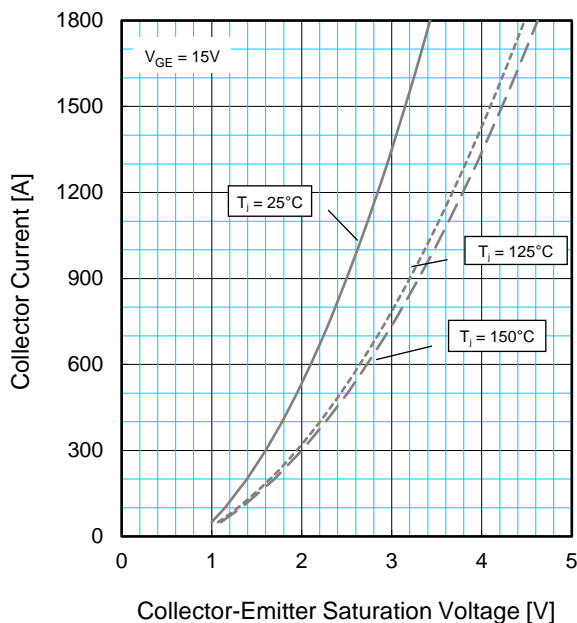
**OUTPUT CHARACTERISTICS (TYPICAL)**



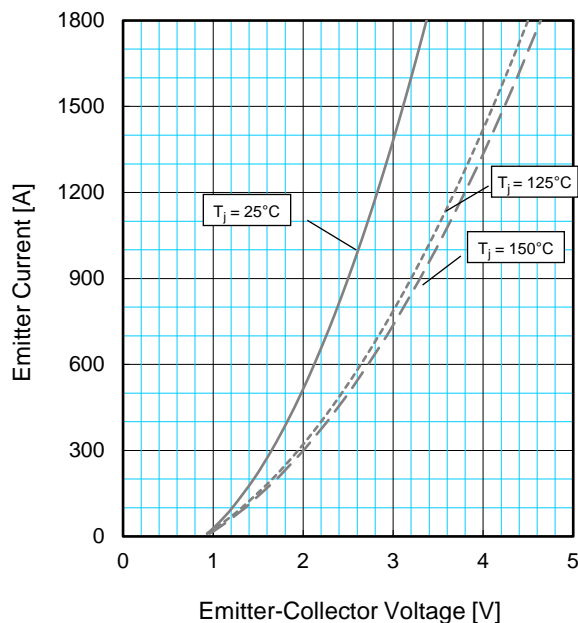
**TRANSFER CHARACTERISTICS (TYPICAL)**



**COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)**



**FREE-WHEEL DIODE FORWARD CHARACTERISTICS (TYPICAL)**



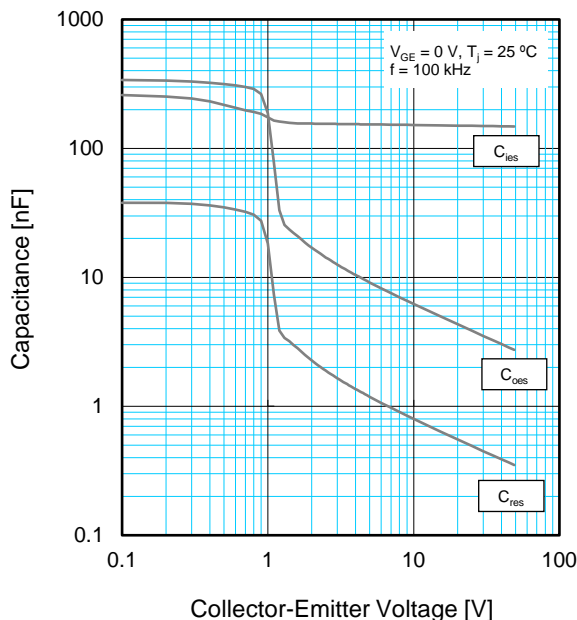
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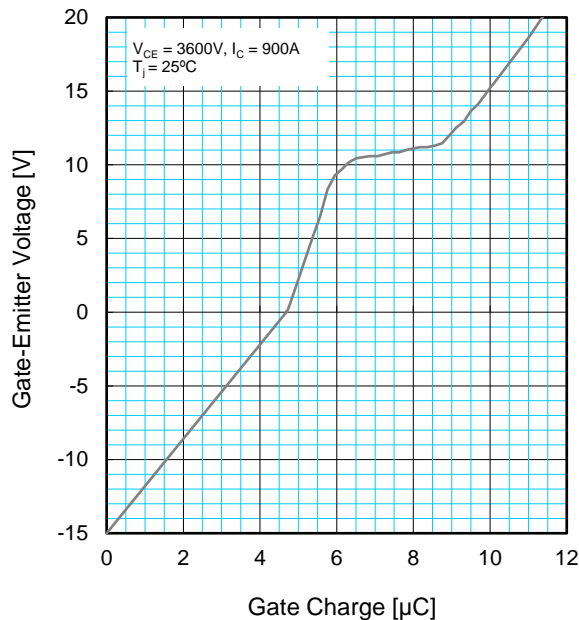
5th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

## PERFORMANCE CURVES

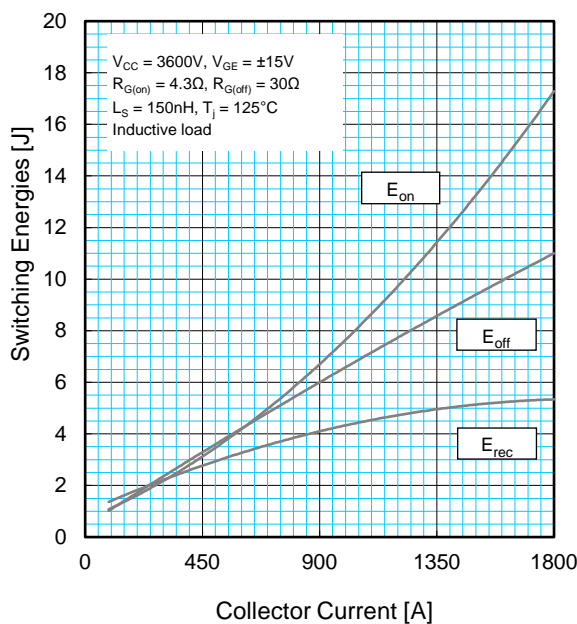
**CAPACITANCE CHARACTERISTICS (TYPICAL)**



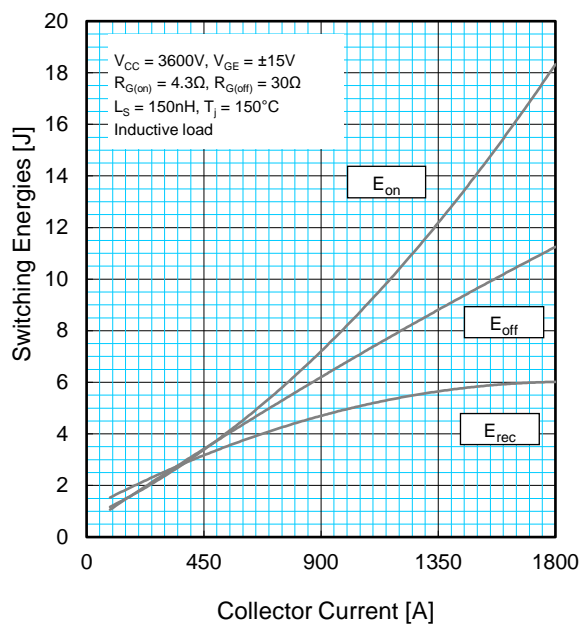
**GATE CHARGE CHARACTERISTICS (TYPICAL)**



**HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)**



**HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)**



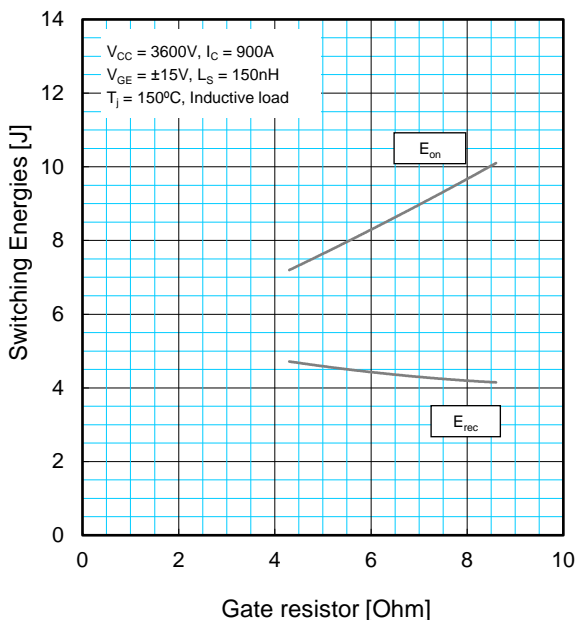
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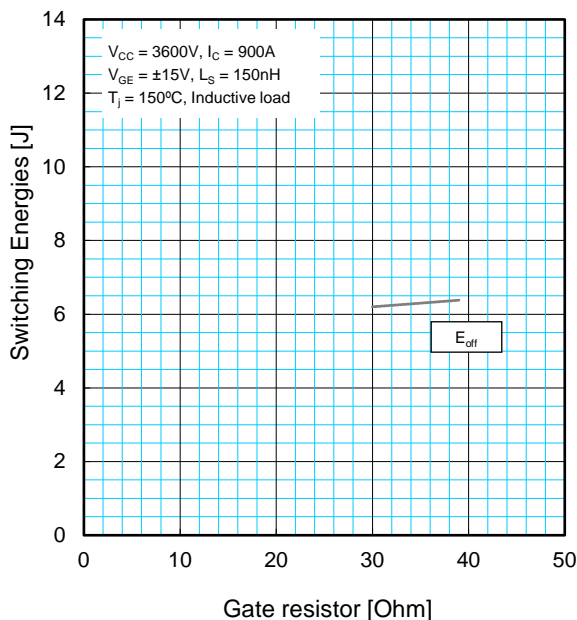
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## PERFORMANCE CURVES

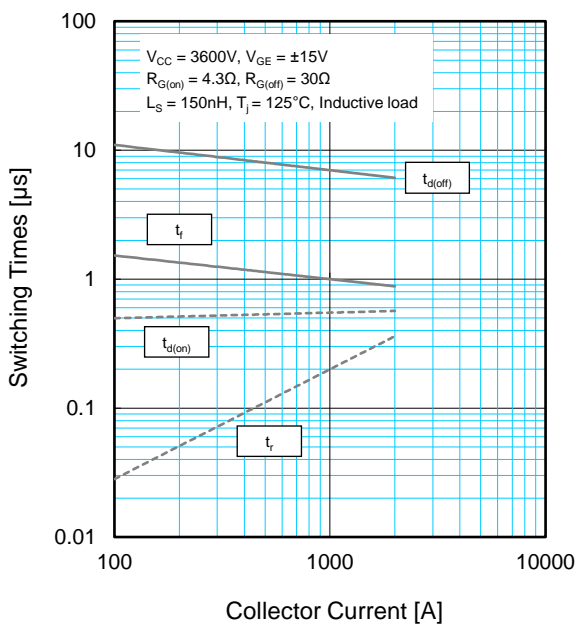
**HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)**



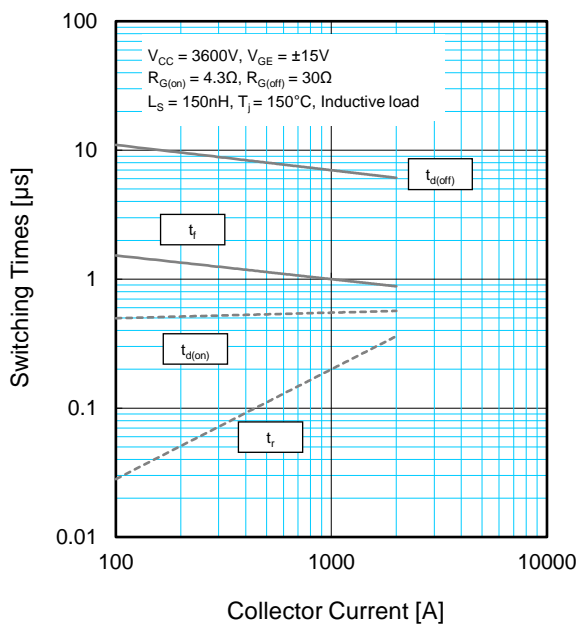
**HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)**



**HALF-BRIDGE SWITCHING TIME CHARACTERISTICS (TYPICAL)**



**HALF-BRIDGE SWITCHING TIME CHARACTERISTICS (TYPICAL)**



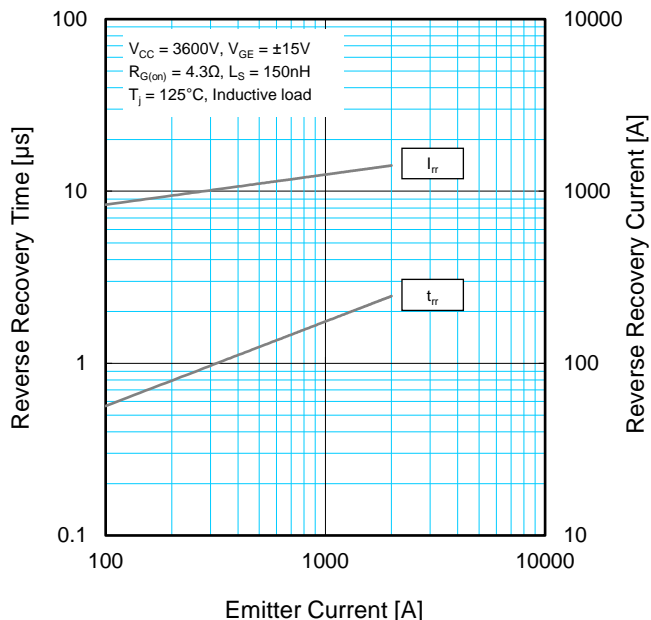
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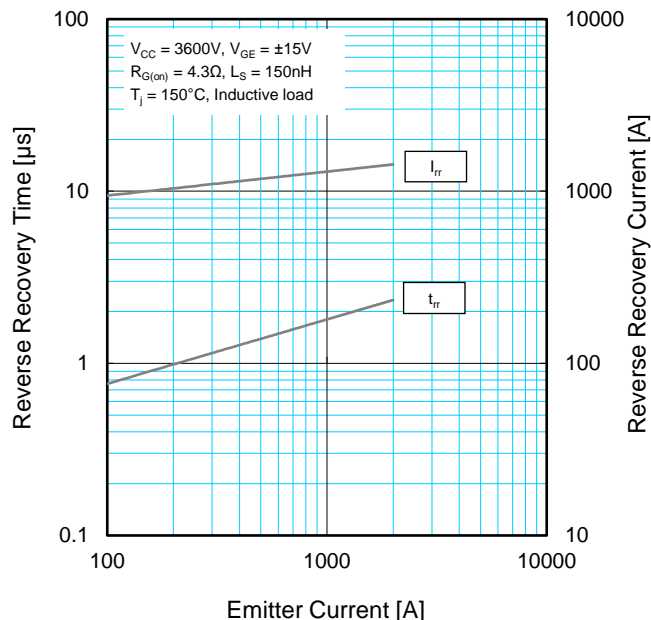
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## PERFORMANCE CURVES

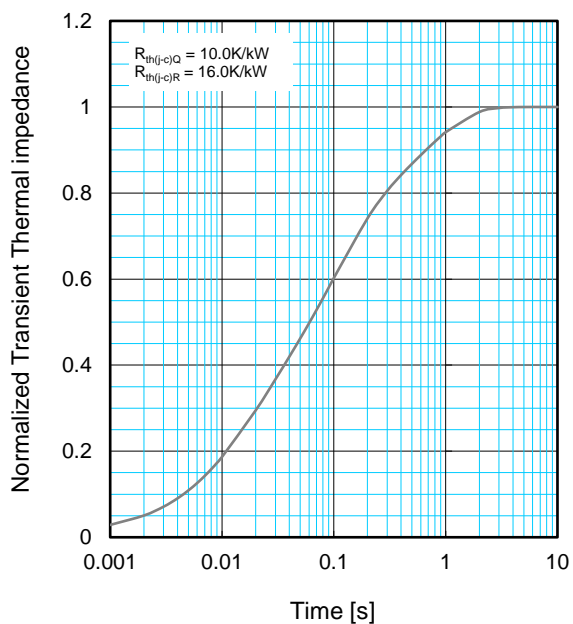
**FREE-WHEEL DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)**



**FREE-WHEEL DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)**



**TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS**



$$Z_{th(j-c)}(t) = \sum_{i=1}^n R_i \left\{ 1 - \exp\left(-\frac{t}{\tau_i}\right) \right\}$$

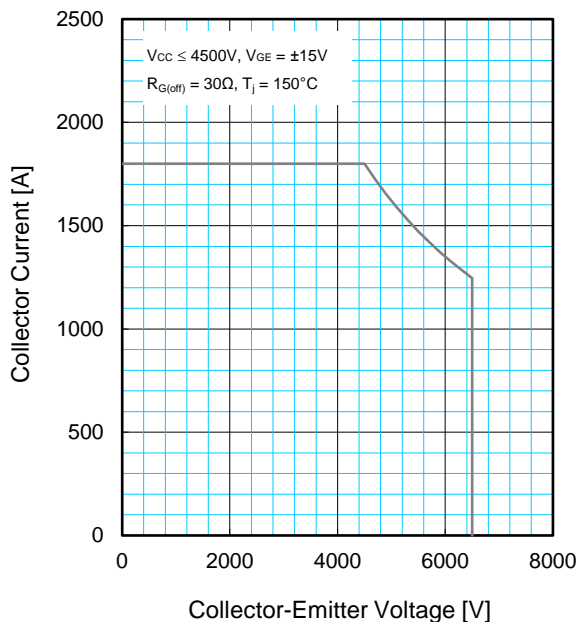
	1	2	3	4
$R_i / R_{th(j-c)}$	0.0096	0.1893	0.4044	0.3967
$\tau_i$ [sec]	0.0001	0.0058	0.0602	0.3512

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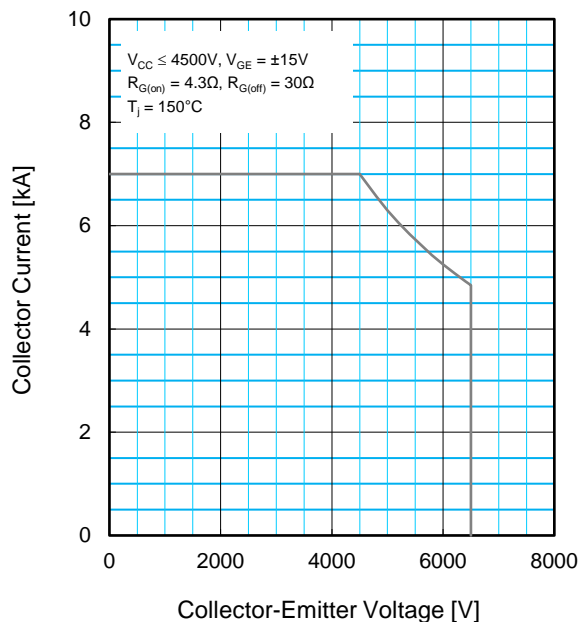
HIGH POWER SWITCHING USE  
INSULATED TYPE

## PERFORMANCE CURVES

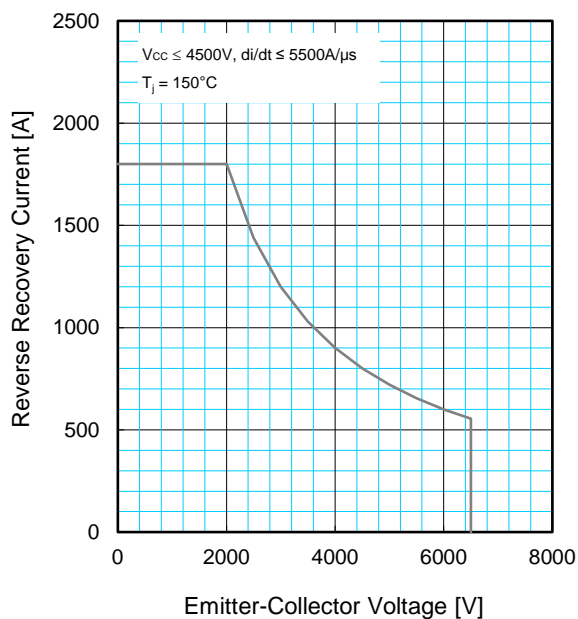
**REVERSE BIAS SAFE OPERATING AREA (RBSOA)**



**SHORT CIRCUIT SAFE OPERATING AREA (SCSOA)**



**FREE-WHEEL DIODE REVERSE RECOVERY SAFE OPERATING AREA (RRSOA)**





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